

ON Semiconductor®

FDH50N50 / FDA50N50 N-Channel UniFETTM MOSFET 500 V, 48 A, 105 m Ω

Features

- $R_{DS(on)} = 89 \text{ m}\Omega \text{ (Typ.)} @ V_{GS} = 10 \text{ V, } I_D = 24 \text{ A}$
- · Low Gate Charge (Typ. 105 nC)
- Low C_{rss} (Typ. 45 pF)
- · 100% Avalanche Tested
- · Improved dv/dt Capability

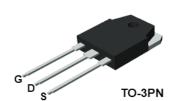
Description

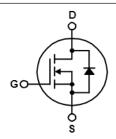
UniFETTM MOSFET is ON Semiconductor's high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.

Applications

- · Lighting
- · Uninterruptible Power Supply
- · AC-DC Power Supply







Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter			FDH50N50-F133 / FDA50N50	Unit
V _{DSS}	Drain-Source Voltage			500	V
I _D	Drain Current	- Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		48 30.8	A A
I _{DM}	Drain Current	- Pulsed	(Note 1)	192	Α
V _{GSS}	Gate-Source voltage			±20	V
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	1868	mJ
I _{AR}	Avalanche Current		(Note 1)	48	Α
E _{AR}	Repetitive Avalanche Energy		(Note 1)	62.5	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	20	V/ns
P _D	Power Dissipation	(T _C = 25°C) - Derate Above 25°C		625 5	W W/°C
T _{J,} T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C
T _L	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds			300	°C

Thermal Characteristics

Symbol	Parameter	FDH50N50-F133 / FDA50N50	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max. 0.2		°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	40	C/VV	

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FDH50N50-F133	FDH50N50	TO-247	Tube	N/A	N/A	30 units
FDA50N50	FDA50N50	TO-3PN	Tube	N/A	N/A	30 units

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Charac	cteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	urce Breakdown Voltage V _{GS} = 0 V, I _D = 250 μA				V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		0.5		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 500 V, V _{GS} = 0 V V _{DS} = 400 V, T _C = 125°C			25 250	μ Α μ Α
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -20 V, V _{DS} = 0 V			-100	nA
On Charac	cteristics				•	
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 24 A		0.089	0.105	Ω
g _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 48 A		20		S
Dynamic C	Characteristics					
C _{iss}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V,		4979	6460	pF
C _{oss}	Output Capacitance	f = 1 MHz		760	1000	pF
C _{rss}	Reverse Transfer Capacitance			50	65	pF
C _{oss}	Output Capacitance	V _{DS} = 400 V, V _{GS} = 0 V, f = 1 MHz		161		pF
C _{oss(eff.)}	Effective Output Capacitance	V _{DS} = 0 V to 400 V, V _{GS} = 0 V		342		pF
	Characteristics					
t _{d(on)}	Turn-On Delay Time	V _{DD} = 250 V, I _D = 48 A,		105	220	ns
t _r	Turn-On Rise Time	$V_{GS} = 10 \text{ V, R}_{G} = 25 \Omega$		360	730	ns
t _{d(off)}	Turn-Off Delay Time			225	460	ns
t _f	Turn-Off Fall Time	(Note 4)		230	470	ns
Qg	Total Gate Charge	V _{DS} = 400 V, I _D = 48 A		105	137	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V		33		nC
Q _{gd}	Gate-Drain Charge	(Note 4)		45		nC
Drain-Sou	rce Diode Characteristics and Maximur	n Ratings			'	
I _S	Maximum Continuous Drain-Source Diode Forward Current				48	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				192	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 48 A			1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 48 A,		580		ns
Q _{rr}	Reverse Recovery Charge	dI _F /dt =100 A/μs		10		μC

- 1. Repetitive rating: pulse-width limited by maximum junction temperature. 2. L = 1.46 mH, I_{AS} = 48 A, V_{DD} = 50 V, R_{G} = 25 Ω , starting T_{J} = 25°C. 3. I_{SD} ≤ 48 A, di/dt ≤ 200 A/ μ s, V_{DD} ≤ BV_{DSs}, starting T_{J} = 25°C. 4. Essentially independent of operating temperature typical characteristics.

Typical Performance Characteristics

Figure 1. On-Region Characteristics

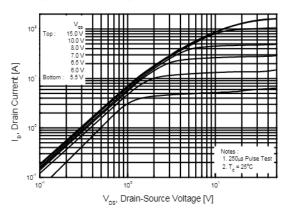


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

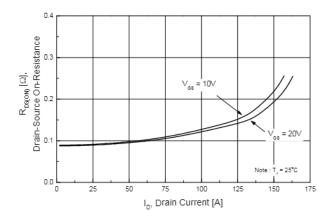


Figure 5. Capacitance Characteristics

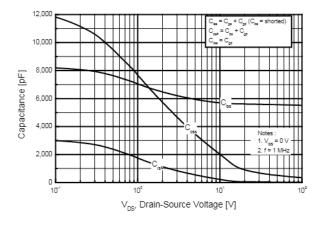


Figure 2. Transfer Characteristics

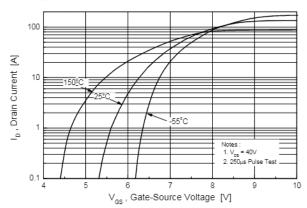


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

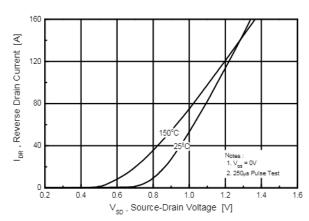
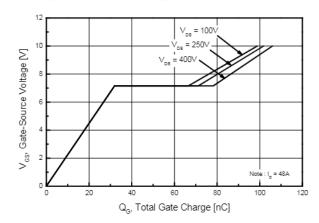


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

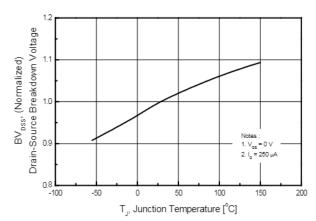


Figure 8. On-Resistance Variation vs. Temperature

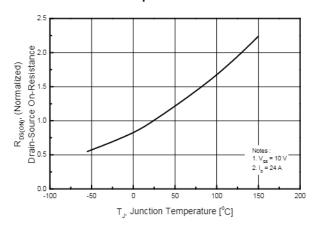


Figure 9. Maximum Safe Operating Area

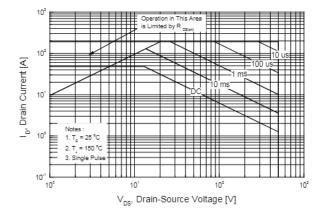


Figure 10. Maximum Drain Current vs. Case Temperature

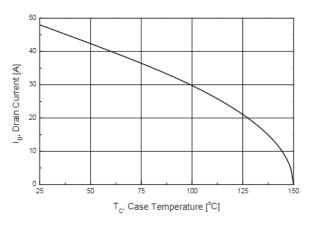


Figure 11. Typical Drain Current Slope vs. Gate Resistance

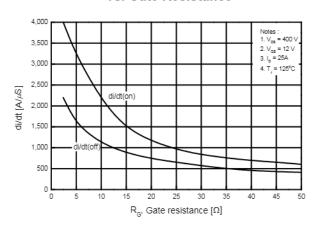
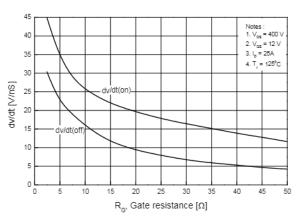


Figure 12. Typical Drain-Source Voltage Slope vs. Gate Resistance



Typical Performance Characteristics (Continued)

Figure 13. Typical Switching Losses vs. Gate Resistance

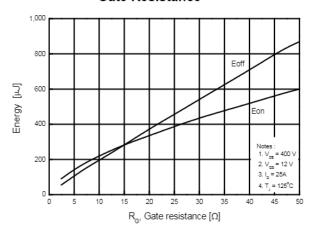


Figure 14. Unclamped Inductive Switching Capability

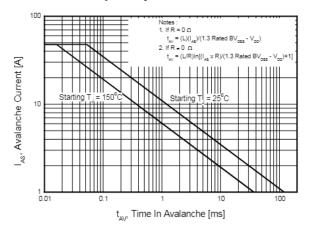
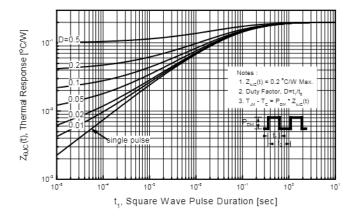


Figure 15. Transient Thermal Resistance Curve



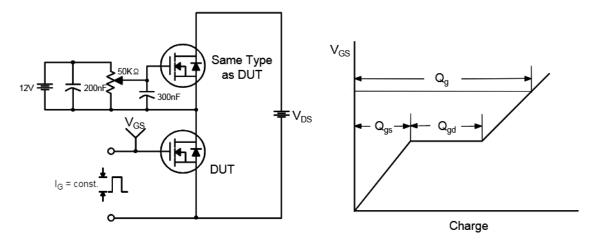


Figure 16. Gate Charge Test Circuit & Waveform

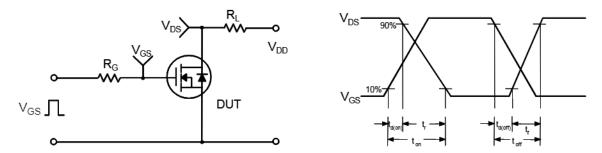


Figure 17. Resistive Switching Test Circuit & Waveforms

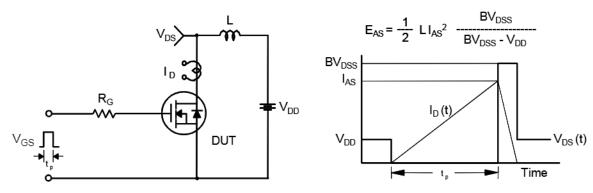
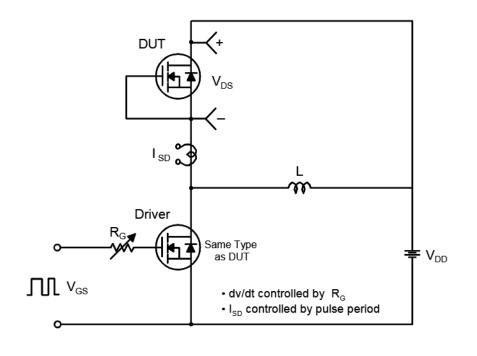


Figure 18. Unclamped Inductive Switching Test Circuit & Waveforms



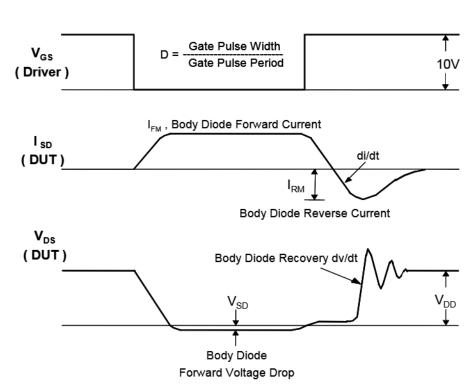
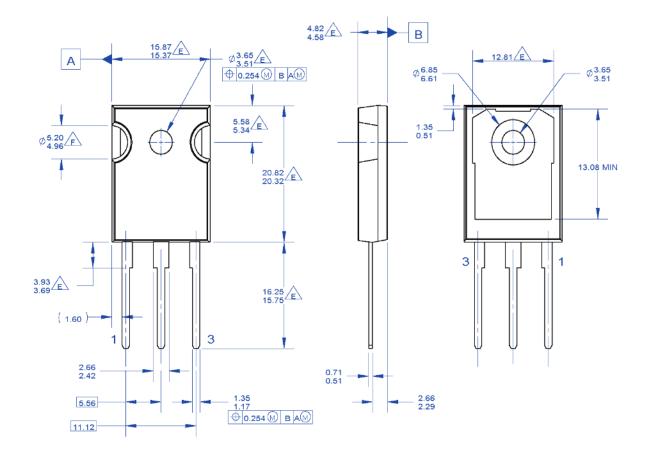


Figure 19. Peak Diode Recovery dv/dt Test Circuit & Waveforms

Mechanical Dimensions



NOTES: UNLESS OTHERWISE SPECIFIED.

- A. PACKAGE REFERENCE: JEDEC TO-247, ISSUE E, VARIATION AB, DATED JUNE, 2004.
- B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH. AND TIE BAR EXTRUSIONS.
- C. ALL DIMENSIONS ARE IN MILLIMETERS.
- D. DRAWING CONFORMS TO ASME Y14.5 1994

DOES NOT COMPLY JEDEC STANDARD VALUE

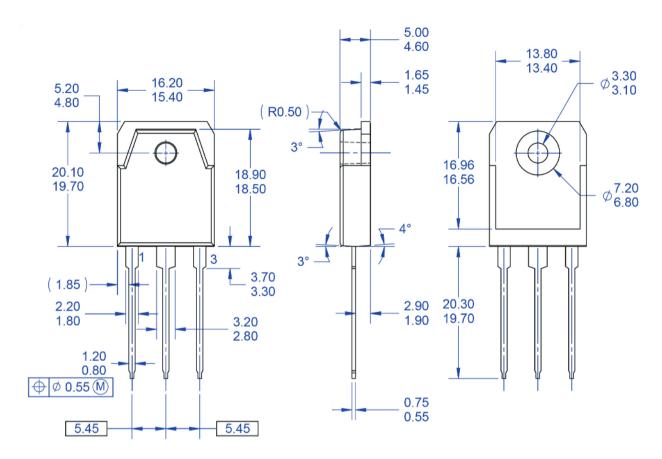
F NOTCH MAY BE SQUARE

G. DRAWING FILENAME: MKT-TO247A03_REV03

Figure 20. TO-247, Molded, 3-Lead, Jedec Variation AB

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Mechanical Dimensions





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 E) DRAWING FILE NAME: TO3PN03AREV1.
- F) FAIRCHILD SEMICONDUCTOR.

Figure 21. TO3PN, 3-Lead, Plastic, EIAJ SC-65

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